9-23-05 COFC/4

EXPRESS MAIL NO.: EV 685780513 US Mailed: September 21, 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of Rong-Chang LIANG, et al.	Art Unit: 2873
Application No. 09/518,488 (Now U.S. Patent No. 6,930,818)	Examiner: TRA, Tuyen Q.
Filed: March 3, 2000 (Now Issued August 16, 2005)	Attorney's Docket No: 07783.0002.NPUS00
For: **ELECTROPHORETIC DISPLAY AND NOVEL PROCESS FOR ITS MANUFACTURE**	

REQUEST FOR CERTIFICATE OF CORRECTION

ATTN: Certificate of Corrections Branch
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Applicant hereby requests the Commissioner to issue a Certificate of Correction for the above-identified U.S. Patent No. 6,930,818 under 37 C.F.R. §1.322 and §1.323. The U.S. Patent and Trademark Office is authorized to charge the requisite fee $100 set forth in § 1.20(a) and any fee deficiency to deposit account 08-3038 references attorney docket number 07783.0002.NPUS00.

Applicants hereby request the following corrections in the above-captioned patent.

OCT 4 2005

THE CORRECTIONS

On the Title Pages:

Page 1, (56), **Reference cited,** Under U.S. PATENT DOCUMENTS

Right Column, line 5, after "5,978,062", insert --

3,229,607	01/1966	Battaglia
3,689,346	09/1972	Rowland
3,885,964	05/1975	Nacci
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5,731,860	03/1998	Harada et al.
5,739,889	04/1998	Yamada et al.
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5,895,541	04/1999	Kobayashi et al.
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6,120,946	9//2000	Johnson et al.
6,166,797	12//2000	Bruzzone et al.
6,191,250	02/2001	Aida et al.

6,400,492	06/2002	Morita et al.
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09/606,654	1/2004	Liang, et al.

--.

Page 1, (56) **Reference cited,** Under FOREIGN PATENT DOCUMENTS

Line 4, change "JP 5917930" to --JP 59171930--.

Line 16, after "WO WO 00/60410 10/2000", insert --

DE	199 27 359.6	12/2000
CA	2,340,683	2/2001
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EP	1065553	01/2001
EP	1195603	04/2002
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JP	02284126	11/1990

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JP	2000-035677	02/2000
JP	2000 075497	03/2000
JP	2001-042118	02/2001
JP	2001-056653	02/2001
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WO	WO 99/08151	02/1999
WO	WO 99/53373	10/1999
WO	WO 00/03291	01/2000
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WO	WO 01/67170	09/2001
WO	WO 02/01281	01/2002

Page 2, right Column, 8th paragraph, line 3, after "Devices-26(8):1148-1152 (1979)", insert --

Drzaic, P.S., "Liquid Crystal Dispersions" , The PDLC Paradigm, pp 1-9, (1995)

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Matsuda Y. "Newly designed, high resolution, active matrix addressing in plane EPD" *IDW 02 EP2-3* 1341-1344 (2002)

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Kishi, E et al, "5.1 Development of In-Plane EPD", Canon Research Center, SID 00 Digest, pp-24-27

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In the Specification:

Column 4, at line 43, change "their" to --its--.

Column 7, at line 35, between "not" and "swollen", insert --be--.

Column 8, at line 44, change"the, residual" to--the residual--.

In the Claims:

Column 16, Claim 25, line 6, change "mode" to -- mold --.

THE REMARKS

The corrections on Cover Page 1 (JP 59171930) and in Columns 8 and 16 are to correct typographical errors incurred through the fault of the U.S. Patent and Trademark Office.

The insertion of the omitted cited references on Cover Pages 1 and 2 are to correct errors incurred through the fault of the U.S. Patent and Trademark Office. A copy of the initialed PTO-1449 (4 pages), which was dated November 21, 2003 by the Examiner, is enclosed herewith. The entire references listed in this PTO-1449 are omitted on the cover pages in the issued patent. Applicants have rearranged the cited references in the Certificate of Correction such that the U.S. Patents are listed in the order of increasing number and foreign patents are listed in the order of country. USSN 09/606,654, which was listed at page 4 of PTO-1449 under OTHER DOCUMENTS, is now listed under U.S. PATENT DOCUMENTS. The '654 Application has been issued as U.S. Patent 6,672,921 on January 6, 2004.

The corrections in columns 4 and 7 are to correct grammatical errors.

Respectfully submitted,

Date: September 21, 2005

Viola T. Kung (Reg. No. 41,131)

Enclosure (Examiner-initialed PTO-1449)

HOWREY, LLP
2941 Fairview Park Drive
Box 7
Falls Church, VA 22042
Tel: (650) 463-8181
Fax: (650) 463-8400

PTO/SB/44 (04-05)
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(Also Form PTO-1050)

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : 6,930,818

APPLICATION NO.: 09/518,488

ISSUE DATE: : August 16, 2005

INVENTOR(S) : Rong-Chang Liang, et al.

It is certified that an error appears or errors appear in the above-identified patent and that said Letters Patent is hereby corrected as shown below:
On the Title Pages:
Page 1, (56), Reference cited, Under U.S. PATENT DOCUMENTS
Right Column, line 5, after "5,978,062", insert --

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OCT 4 2005

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5,995,190	11/1999	Nagae et al.
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In the Claims:

Column 16, Claim 25, line 6, change "mode" to -- mold --.

MAILING ADDRESS OF SENDER (Please do not use customer number below):
HOWREY LLP
2941 Fairview Park Drive, Box 7
Falls Church, VA 22042

OCT 4 2005

INFORMATION DISCLOSURE STATEMENT PTO-1449	ATTY. DOCKET NO. 26822-0002	SERIAL NO. 09/518,488
	APPLICANTS: RONG, Chang-Liang, et al.	
	FILING DATE: 03/03/2000	GROUP: 2873

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
T.T.	5,177,476	01/05/1993	Disanto et al.			
T.T.	5,872,552	02/16/1999	Gordon II et al.			
T.T.	4,655,897	04/07/1987	Disanto et al.			
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T.T.	2002/0188053	12/12/2002	Zang et al.			
T.T.	20020126249	12/05/2002	Chan-Park, et al.			
T.T.	20020126249	09/12/2002	Liang, et al.			

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY (Inventor)	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
T.T.	199 27 359.6	Pub. Date 12/21/00	Germany[1] (Schmidt, F. G.)			☐	☒
T.T.	2,340,683	Nat'l Entry Dt 2/14/2001	Canada (Schmidt, F. G.)			☒	☐
T.T.	EP 1065553	Pub Date 01/03/2001	Europe (Ogawa)			☐	☐
T.T.	EP 0990942	Pub Date 04/05/2000	Europe (Yamanaka)			☐	☐
T.T.	EP 1195603	Pub Date 04/10/2002	Europe (Kawai)			☐	☐
T.T.	JP 6242423	Pub Date 09/02/1994	Japan (Nakai Yuichi) (English abstract included)			☐	☒

[1] See English counterparts US Patent No. 6,512,626 or Canadian Patent Application No. 2,340,683. Applicant would be happy to obtain a direct translation of the document if desired.

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T.T.	JP 2000 075497	Pub Date 03/14/2000	Japan (English abstract included)			☐	☒
T.T.	JP 2001 042118	Pub Date 02/16/2001	Japan (English abstract included)			☐	☒
T.T.	JP 2001 056653	Pub Date 02/27/2001	Japan (Hayakawa) (English abstract included)			☐	☒
T.T.	JP 02284126	Pub Date 11/21/1990	Japan (Oshiro) (English abstract included)			☐	☒
T.T.	WO 97/04398	Pub Date 02/06/1997	PCT (Jacobson)			☐	☐
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T.T.	WO 01/67170	Pub Date 09/13/2001	PCT (Liang et al.)			☐	☐
T.T.	WO 99/08151	Pub Date 02/18/1999	PCT (Bruzzone et al.)			☐	☐
T.T.	WO 00/03291	Pub Date 01/20/2000	PCT (Jacobson et al.)			☐	☐
T.T.	WO 02/01281	Pub Date 01/03/2002	PCT (Liang et al.)			☐	☐
T.T.	WO 99/53373	Pub Date 10/21/1999	PCT (Drzaic)			☐	☐

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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T.T.	USSN 09/606,654, "Manufacturing Process for Electrophoretic Display", filed 6/28/2000 (copy provided upon request)

EXAMINER TUYEN TRA	DATE CONSIDERED 11.21.03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

*If an asterisk is placed beside the reference number, a copy is not provided because the reference was previously cited by or submitted to the PTO in a prior application that is identical in the statement and relied upon for an earlier filing date under 35 U.S.C. §120. 37 C.F.R. §1.98 (d).